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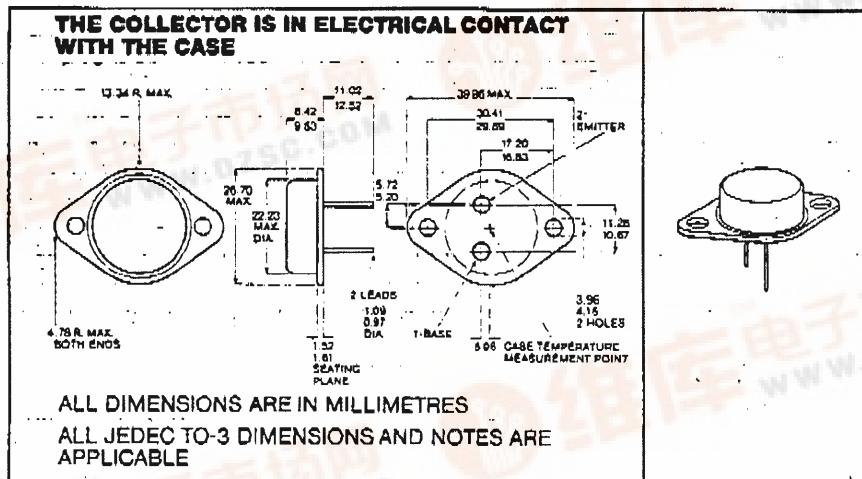


### TYPES 2N6329, 2N6330, 2N6331 P-N-P SILICON POWER TRANSISTORS

FOR POWER-AMPLIFIER AND HIGH-SPEED-SWITCHING APPLICATIONS  
DESIGNED FOR COMPLEMENTARY USE WITH 2N6326, 2N6327, 2N6328

- 200 W at 25°C Case Temperature
- 30-A Rated Collector Current
- 200-mJ Reverse Energy Rating
- High SOA Capability, 20 V and 10 A

\*mechanical data



\*absolute maximum ratings at 25°C case temperature (unless otherwise noted)

	2N6329	2N6330	2N6331
Collector-Base Voltage	-60 V	-80 V	-100 V
Collector-Emitter Voltage (See Note 1)	-60 V	-80 V	-100 V
Emitter-Base Voltage	-5 V	-5 V	-5 V
Continuous Collector Current	→ 30 A	→ 40 A	→ 10 A
Peak Collector Current (See Note 2)	→ See Figures 3 and 4	→ 200 W	→ 114 W
Continuous Base Current	→ 5 W	→ 200 mJ	→ 65°C to 200°C
Safe Operating Areas at (or below) 25°C Case Temperature	→ 200 W	→ 114 W	→ 5 W
Continuous Device Dissipation at (or below) 25°C Case Temperature (See Note 3)	→ 200 W	→ 114 W	→ 5 W
Continuous Device Dissipation at 100°C Case Temperature (See Note 3)	→ 114 W	→ 5 W	→ 200 mJ
Continuous Device Dissipation at (or below) 25°C Free-Air Temperature (See Note 4)	→ 114 W	→ 5 W	→ 65°C to 200°C
Unclamped Inductive Load Energy (See Note 5)	→ 5 W	→ 200 mJ	→ 250°C
Operating Collector Junction Temperature Range	→ 200 mJ	→ 65°C to 200°C	→ 250°C
Storage Temperature Range	→ 65°C to 200°C	→ 250°C	→ 250°C
Terminal Temperature 1.6mm from Case for 10 Seconds	→ 250°C	→ 250°C	→ 250°C

- NOTES: 1. These values apply when the base-emitter diode is open-circuited.  
 2. This value applies for  $t_{sw} \leq 1$  ms, duty cycle  $\leq 10\%$ .  
 3. Derate linearly to 200°C case temperature at the rate of 1.14 W/°C or refer to Dissipation Derating Curve, Figure 5.  
 4. Derate linearly to 200°C free-air temperature at the rate of 28.6 mW/°C or refer to Dissipation Derating Curve, Figure 6.  
 5. This rating is based on the capability of the transistors to operate safely in the circuit of Figure 2.  $L = 20$  mH,  $R_{BB2} = 100 \Omega$ ,  $V_{BB2} = 0$  V,  $R_S = 0.1 \Omega$ ,  $V_{CC} = 20$  V. Energy =  $I_C^2 L / 2$ .

JEDEC registered data. This data sheet contains all applicable registered data in effect at the time of publication.



**TYPES 2N6329, 2N6330, 2N6331**  
**P-N-P SILICON POWER TRANSISTORS**

\*electrical characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	2N6329		2N6330		2N6331		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
V(BR)CEO	Collector-Emitter Breakdown Voltage	I <sub>C</sub> = -30 mA, I <sub>B</sub> = 0, See Note 6	-60	-80	-100	-120	-140	V
I <sub>CEO</sub>	V <sub>CE</sub> = -30 V, I <sub>B</sub> = 0	-1	-1	-1	-1	-1	-1	mA
	V <sub>CE</sub> = -40 V, I <sub>B</sub> = 0	-1	-1	-1	-1	-1	-1	
	V <sub>CE</sub> = -50 V, I <sub>B</sub> = 0	-1	-1	-1	-1	-1	-1	
I <sub>CES</sub>	V <sub>CE</sub> = -60 V, V <sub>BE</sub> = 0	-0.5	-0.5	-0.5	-0.5	-0.5	-0.5	mA
	V <sub>CE</sub> = -80 V, V <sub>BE</sub> = 0	-0.5	-0.5	-0.5	-0.5	-0.5	-0.5	
	V <sub>CE</sub> = -100 V, V <sub>BE</sub> = 0	-0.5	-0.5	-0.5	-0.5	-0.5	-0.5	
	V <sub>CE</sub> = -30 V, V <sub>BE</sub> = 0, T <sub>C</sub> = 150°C	-5	-5	-5	-5	-5	-5	
	V <sub>CE</sub> = -40 V, V <sub>BE</sub> = 0, T <sub>C</sub> = 150°C	-5	-5	-5	-5	-5	-5	
	V <sub>CE</sub> = -50 V, V <sub>BE</sub> = 0, T <sub>C</sub> = 150°C	-5	-5	-5	-5	-5	-5	
I <sub>EBO</sub>	Emitter Cutoff Current	V <sub>EB</sub> = -5 V, I <sub>C</sub> = 0	-0.5	-0.5	-0.5	-0.5	-0.5	mA
h <sub>FE</sub>	Static Forward Current Transfer Ratio	V <sub>CE</sub> = -4 V, I <sub>C</sub> = -5 A	25	25	25	25	25	
	V <sub>CE</sub> = -4 V, I <sub>C</sub> = -15 A	See Notes 6 and 7	12	12	12	12	12	
	V <sub>CE</sub> = -4 V, I <sub>C</sub> = -30 A	6	30	6	30	6	30	
V <sub>BE</sub>	Base-Emitter Voltage	V <sub>CE</sub> = -4 V, I <sub>C</sub> = -15 A	-2	-2	-2	-2	-2	V
	V <sub>CE</sub> = -4 V, I <sub>C</sub> = -30 A	See Notes 6 and 7	-4	-4	-4	-4	-4	
V <sub>CE(sat)</sub>	Collector-Emitter Voltage	I <sub>B</sub> = -2 A, I <sub>C</sub> = -15 A	-1.5	-1.5	-1.5	-1.5	-1.5	V
	I <sub>B</sub> = -7.5 A, I <sub>C</sub> = -30 A	See Notes 6 and 7	-3	-3	-3	-3	-3	
h <sub>fe</sub>	Small-Signal Common-Emitter Forward Current Transfer Ratio	V <sub>CE</sub> = -10 V, I <sub>C</sub> = -1 A, f = 1 kHz	30	30	30	30	30	
	Small-Signal Common-Emitter Forward Current Transfer Ratio	V <sub>CE</sub> = -10 V, I <sub>C</sub> = -1 A, f = 1 MHz	3	3	3	3	3	

NOTES: 6. These parameters must be measured using pulse techniques, t<sub>w</sub> = 300 μs; duty cycle ≤ 2%.

7. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts and located within 3.2 mm from the device body.

TJEDEC registered date

switching characteristics at 25°C case temperature

PARAMETER	TEST CONDITIONS <sup>†</sup>	TYP	UNIT
t <sub>on</sub>	Turn-On Time	I <sub>C</sub> = -15 A, I <sub>B(1)</sub> = -2 A, I <sub>B(2)</sub> = 2 A,	0.6
t <sub>off</sub>	Turn-Off Time	V <sub>BE(off)</sub> = 4 V, R <sub>L</sub> = 2 Ω, See Figure 1	0.9

<sup>†</sup>Voltage and current values shown are nominal, exact values vary slightly with transistor parameters.